



Dual N-Channel 20 V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}$ (Ω)	I _D (A) ^a	Q _g (Typ.)		
	0.168 at V _{GS} = 4.5 V	1.3 ^a			
20	0.200 at $V_{GS} = 2.5 \text{ V}$	1.3 ^a	1.6 nC		
	0.250 at V _{GS} = 1.8 V	1.3 ^a			

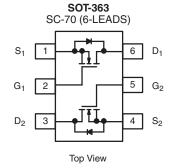
FEATURES

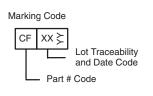
- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET[®] Power MOSFET
- Compliant to RoHS Directive 2002/95/EC

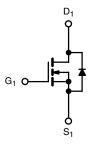


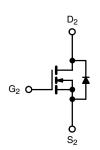
APPLICATIONS

Load Switch for Portable Applications









Ordering Information: Si1988DH-T1-E3 (Lead (Pb)-free)

Si1988DH-T1-GE3 (Lead (Pb)-free and Halogen-free)

N-Channel MOSFET

N-Channel MOSFET

Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	20	V	
Gate-Source Voltage		V_{GS}	± 8		
	T _C = 25 °C		1.3 ^a		
Continuous Dusin Comment (T., 150 °C)	T _C = 70 °C		1.3 ^a		
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	I _D	1.3 ^{a, b, c}		
	T _A = 70 °C		1.3 ^{a, b, c}	А	
Pulsed Drain Current	I _{DM}	4			
Continuous Source-Drain Diode Current	T _C = 25 °C	1	1.0		
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	0.61 ^{b, c}		
	T _C = 25 °C		1.25		
Maximum Power Dissipation	T _C = 70 °C	В	0.8	\Box w	
Maximum Fower Dissipation	T _A = 25 °C	P _D	0.74 ^{b, c}		
	T _A = 70 °C		0.47 ^{b, c}		
Operating Junction and Storage Temperature Ra	T _J , T _{stg}	- 55 to 150	°C		
Soldering Recommendations (Peak Temperature	-	260			

THERMAL RESISTANCE RATINGS						
Parameter	Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient ^{b, f}	t ≤ 5 s	R _{thJA}	130	170	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	R _{thJF}	80	100		

Notes

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 5 s.
- d. Maximum under steady state conditions is 220 $^{\circ}\text{C/W}.$

Si1988DH

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Static Drain-Source Breakdown Voltage V_{DS} $V_{GS} = 0 \text{ V}$, $I_D = 250 \text{ μA}$ 20 V Vps Temperature Coefficient $\Delta V_{DS}/T_L$ 19.7	SPECIFICATIONS T _J = 25 °C, unless otherwise noted								
	Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit		
V _{DS} Temperature Coefficient AV _{DS} (T) V _{OS(M)} Temperature Coefficient AV _{DS} (T) V _{DS} (T) AV _{DS} (T) V _{DS}	Static					•	1		
V _{DS} Temperature Coefficient AV _{DS} (T) V _{OS(M)} Temperature Coefficient AV _{DS} (T) V _{DS} (T) AV _{DS} (T) V _{DS}	Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V, I}_{D} = 250 \mu\text{A}$	20			V		
Vasion Temperature Coefficient ΔVGS(m)/Tyl VDS = VGS, ID = 250 μA - 2.4 I V Gate-Source Threshold Voltage VGS(m) VDS = VGS, ID = 250 μA 0.4 1 V Zero Gate Voltage Drain Current IGSS VDS = 0 V, VGS = 8 V ± 100 ns On-State Drain Current [®] ID(on) VDS = 20 V, VGS = 0 V, TJ = 55 °C 10 A On-State Drain Current [®] ID(on) VDS = 5 V, VGS = 4 V, UD = 1.4 A 0.139 0.168 A Drain-Source On-State Resistance [®] PRDS(on) VDS = 4 V, UD = 1.4 A 0.165 0.200 0.205 0.250 0.205 0.250 0.205 0.250 0.205 0.250 0.205 0.250 0.205 0.250 0.205 0.250 0.205 0.250 0.205 0.205 0.205 0.205 0.205 0.205 0.205	V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$			19.7		mV/°C		
Cate-Source Leakage	V _{GS(th)} Temperature Coefficient		I _D = 250 μA		- 2.4				
Gate-Source Leakage I _{GSS} V _{DS} = 0 V, V _{GS} = ± 8 V	Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	0.4		1	V		
2 2 2 2 2 2 2 2 2 2	Gate-Source Leakage		$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8 \text{ V}$			± 100	ns		
No. State Drain Current ^a 1 _{D(m)} V _{DS} = 20 V, V _{GS} = 4.5 V 4	Zara Oata Williama Brain Oarrani		V _{DS} = 20 V, V _{GS} = 0 V			1	μΑ		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Zero Gate voltage Drain Current		$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			10			
Drain-Source On-State Resistance ^a R _{DS} (on) V _{GS} = 2.5 V, I _D = 1.3 A 0.165 0.200 Ω Forward Transconductance ^a g _{IS} V _{DS} = 4 V, I _D = 0.4 A 0.205 0.250 Ω Dynamic ^b Use of the properties of the	On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le 5 \text{ V}, V_{GS} = 4.5 \text{ V}$	4			Α		
V _{GS} = 1.8 V, I _D = 0.4 A 0.205 0.250		, ,	V _{GS} = 4.5 V, I _D = 1.4 A		0.139	0.168	1		
No.	Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 2.5 V, I _D = 1.3 A		0.165	0.200	Ω		
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $, ,	V _{GS} = 1.8 V, I _D = 0.4 A		0.205	0.250	1		
$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$	Forward Transconductance ^a	9 _{fs}	$V_{DS} = 4 \text{ V}, I_{D} = 1.4 \text{ A}$		4		S		
Output Capacitance Coss Coss Reverse Transfer Capacitance V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz 25 pF Total Gate Charge O _G V _{DS} = 10 V, V _{GS} = 8 V, I _D = 1.6 A 2.7 4.1 A1.6 2.4 A1.6	Dynamic ^b	1				l .			
Output Capacitance C _{Oss} Reverse Transfer Capacitance V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz 25	Input Capacitance	C _{iss}			110		pF		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Output Capacitance	+	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz		25				
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Reverse Transfer Capacitance	C _{rss}			11				
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	T. 10 . 0	Q _g	$V_{DS} = 10 \text{ V}, V_{GS} = 8 \text{ V}, I_D = 1.6 \text{ A}$		2.7	4.1	nC		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	lotal Gate Charge				1.6	2.4			
Gate-Drain Charge Qgd f = 1 MHz 0.25 □ Gate Resistance Rg f = 1 MHz 4 Ω Turn-On Delay Time tq(on) VDD = 10 V, RL = 7.7 Ω 20 30 Fise Time tf 10 = 1.3 A, VGEN = 4.5 V, Rg = 1 Ω 15 25 Fall Time tf 10 = 1.3 A, VGEN = 8 V, Rg = 1 Ω 5 10 Turn-on Delay Time tf VDD = 10 V, RL = 7.7 Ω 11 20 Rise Time tr VDD = 10 V, RL = 7.7 Ω 11 20 Turn-Off Delay Time tf VDD = 10 V, RL = 7.7 Ω 11 20 Fall Time tr VDD = 1.3 A, VGEN = 8 V, Rg = 1 Ω 10 15 Fall Time tr TD = 1.3 A, VGEN = 8 V, Rg = 1 Ω 10 15 Pull Time tr TD = 1.3 A, VGEN = 8 V, Rg = 1 Ω 10 15 Pull Time TC = 25 °C 1 4 A Pull Se Diode Forward Current Is TC = 25 °C 1 A A Body Diode Reverse Recovery Time	Gate-Source Charge				0.3				
$ \begin{array}{ c c c c c c } \hline \text{Gate Resistance} & R_g & f = 1 \text{MHz} & 4 & \Omega \\ \hline \text{Turn-On Delay Time} & t_{d(on)} & & & & & 12 \\ \hline \text{Rise Time} & t_r & V_{DD} = 10 \text{V}, R_L = 7.7 \Omega & 20 & 30 \\ \hline \text{Turn-Off Delay Time} & t_d(off) & & & & 15 & 25 \\ \hline \text{Fall Time} & t_r & & & & 5 & 10 \\ \hline \text{Turn-on Delay Time} & t_{d(off)} & & & & 5 & 10 \\ \hline \text{Rise Time} & t_r & & & & 5 & 10 \\ \hline \text{Turn-Off Delay Time} & t_{d(off)} & & & & 5 & 10 \\ \hline \text{Rise Time} & t_r & & & & 5 & 10 \\ \hline \text{Turn-Off Delay Time} & t_{d(off)} & & & & 5 & 10 \\ \hline \text{Turn-Off Delay Time} & t_{d(off)} & & & & & 11 & 20 \\ \hline \text{Turn-Off Delay Time} & t_{d(off)} & & & & & 11 & 20 \\ \hline \text{Turn-Off Delay Time} & t_r & & & & & 10 & 15 \\ \hline \text{Fall Time} & & & & & & & 11 & 20 \\ \hline \textbf{Pain-Source Body Diode Characteristics} & & & & & & 11 & 20 \\ \hline \textbf{Drain-Source Body Diode Characteristics} & & & & & & 10 & 15 \\ \hline \textbf{Pulse Diode Forward Current} & I_S & & & & & & & & 14 \\ \hline \textbf{Body Diode Voltage} & & & & & & & & & 14 \\ \hline \textbf{Body Diode Reverse Recovery Time} & & & & & & & & 14 \\ \hline \textbf{Body Diode Reverse Recovery Charge} & & & & & & & & & 20 & 40 & nc \\ \hline \textbf{Reverse Recovery Fall Time} & & & & & & & & & & & ns \\ \hline \end{array}$	Gate-Drain Charge				0.25				
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Gate Resistance	_	f = 1 MHz		4		Ω		
$ \begin{array}{ c c c c c }\hline \text{Rise Time} & t_r & V_{DD} = 10 \text{ V}, R_L = 7.7 \Omega \\ \hline \text{Turn-Off Delay Time} & t_{d(off)} & 15 & 25 \\ \hline \text{Fall Time} & t_f & 10 & 15 \\ \hline \text{Turn-on Delay Time} & t_{d(on)} & & & 5 & 10 \\ \hline \text{Rise Time} & t_r & V_{DD} = 10 \text{ V}, R_L = 7.7 \Omega \\ \hline \text{Turn-Off Delay Time} & t_r & & 5 & 10 \\ \hline \text{Turn-Off Delay Time} & t_{d(off)} & & & 5 & 10 \\ \hline \text{Fall Time} & t_r & & & 11 & 20 \\ \hline \text{Turn-Off Delay Time} & t_{d(off)} & & & & 11 & 20 \\ \hline \text{Fall Time} & & t_r & & & 6 & 10 \\ \hline \textbf{Drain-Source Body Diode Characteristics} & & & & & & & \\ \hline \textbf{Continuous Source-Drain Diode Current} & I_S & T_C = 25 ^{\circ}\text{C} & & 1 & A \\ \hline \textbf{Pulse Diode Forward Current} & I_{SM} & & & 4 \\ \hline \textbf{Body Diode Reverse Recovery Time} & t_{rr} & & & 20 & 40 & ns \\ \hline \textbf{Body Diode Reverse Recovery Charge} & Q_{rr} & & & & & \\ \hline \textbf{Reverse Recovery Fall Time} & t_a & & & & & \\ \hline \end{array}$	Turn-On Delay Time				8	12	ns		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Rise Time				20	30			
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Turn-Off Delay Time	t _{d(off)}			15	25			
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Fall Time				10	15			
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Turn-on Delay Time				5	10			
Fall Time tr 6 10 Drain-Source Body Diode Characteristics Continuous Source-Drain Diode Current I_S $T_C = 25 ^{\circ}\text{C}$ 1 A Pulse Diode Forward Current I_{SM} 4 Body Diode Voltage V_{SD} $I_S = 1.3 \text{A}, V_{GS} = 0 ^{\circ}\text{V}$ $0.8 1.2 ^{\circ}\text{V}$ Body Diode Reverse Recovery Time t_{rr} Body Diode Reverse Recovery Charge Q_{rr} Reverse Recovery Fall Time t_a $I_F = 1.3 \text{A}, \text{dl/dt} = 100 \text{A/µs}, T_J = 25 ^{\circ}\text{C}$ $I_F = 1.3 \text{A}, \text{dl/dt} = 100 \text{A/µs}, T_J = 25 ^{\circ}\text{C}$	Rise Time		$V_{DD} = 10 \text{ V}, R_{L} = 7.7 \Omega$		11	20			
	Turn-Off Delay Time	t _{d(off)}	$I_D \cong 1.3 \text{ A}, V_{GEN} = 8 \text{ V}, R_g = 1 \Omega$		10	15			
	Fall Time				6	10			
Pulse Diode Forward Current I_{SM} Body Diode Voltage V_{SD} Body Diode Reverse Recovery Time t_{rr} Body Diode Reverse Recovery Charge Q_{rr} Reverse Recovery Fall Time t_a $I_{S} = 1.3 \text{ A}, V_{GS} = 0 \text{ V}$ $I_{S} = 1.3 \text{ A}, V_{$	Drain-Source Body Diode Characteristic	:s				l .	1		
Pulse Diode Forward Current I_{SM} 4 Body Diode Voltage V_{SD} $I_S = 1.3 \text{ A}, V_{GS} = 0 \text{ V}$ $0.8 1.2 \text{ V}$ Body Diode Reverse Recovery Time t_{rr} $20 40 \text{ ns}$ Body Diode Reverse Recovery Charge Q_{rr} Reverse Recovery Fall Time t_a $I_F = 1.3 \text{ A}, \text{dI/dt} = 100 \text{ A/µs}, T_J = 25 \text{ °C}$	Continuous Source-Drain Diode Current	Is	T _C = 25 °C			1	A		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Pulse Diode Forward Current	1				4			
Body Diode Reverse Recovery Time t_{rr} Body Diode Reverse Recovery Charge Q_{rr} Reverse Recovery Fall Time t_a	Body Diode Voltage		I _S = 1.3 A, V _{GS} = 0 V		0.8	1.2	V		
Body Diode Reverse Recovery Charge Q_{rr} $I_F = 1.3 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$ $0.0 0.0 $					20	40	ns		
Reverse Recovery Fall Time t _a 16 ns			I _F = 1.3 A, dl/dt = 100 A/μs, T _J = 25 °C		20	40	nC		
ns ns					16				

Notes:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %.

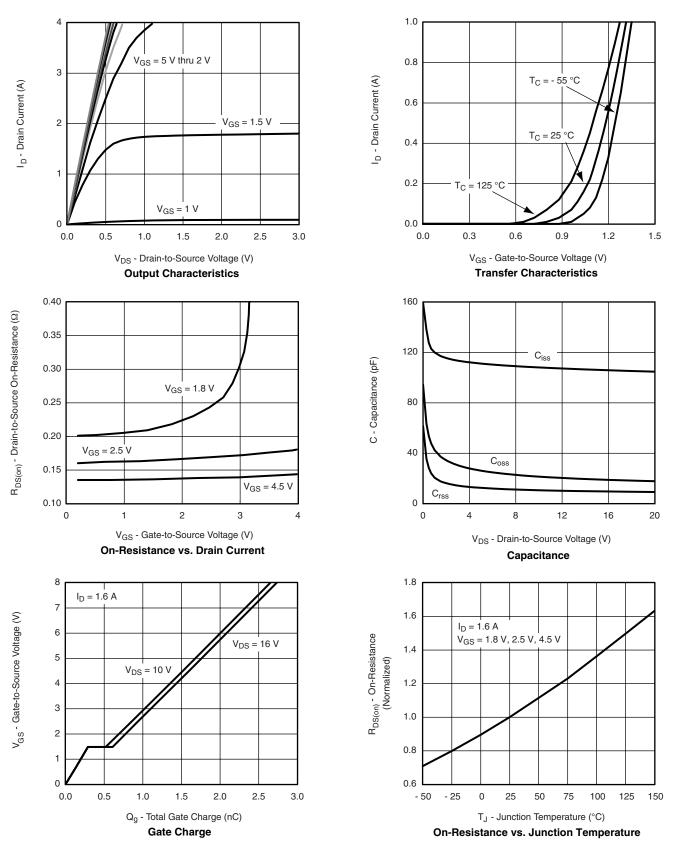
b. Guaranteed by design, not subject to production testing.







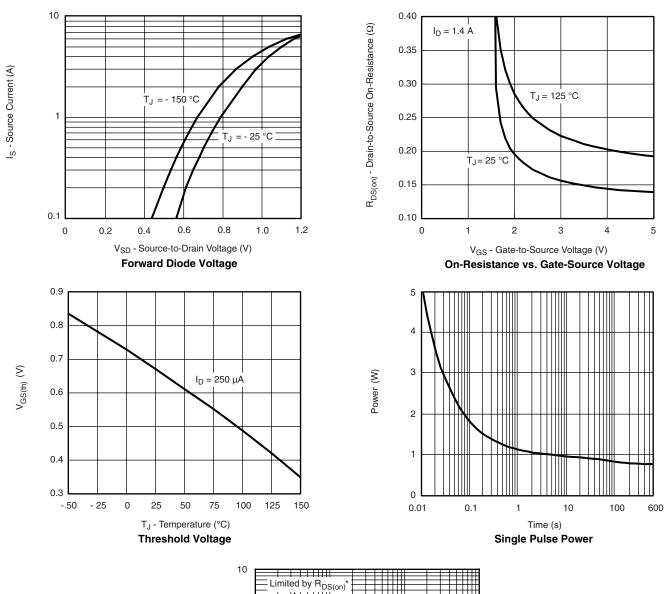
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

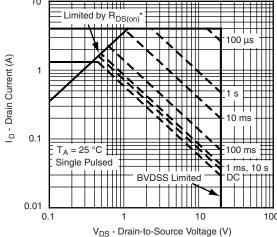


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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted





* V_{GS} > minimum V_{GS} at which R_{DS(on)} is specified

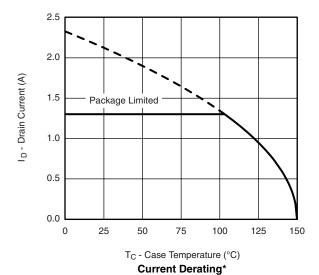
Safe Operating Area, Junction-to-Case

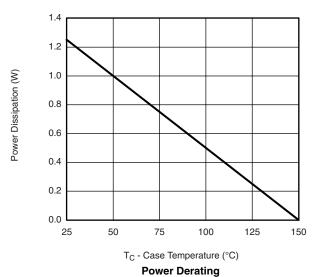






TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



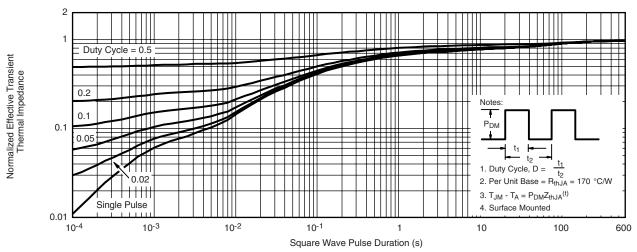


^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit

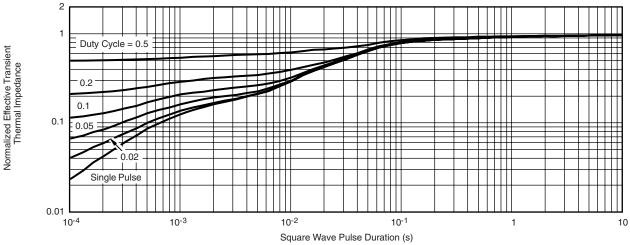
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppq?74296.



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